

Notice of References Cited	Application/Control No. 10/596,118		Applicant(s)/Patent Under Reexamination ISHIO ET AL.	
	Examiner HYUN PARK		Art Unit 4154	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,490,065	02-1996	Hoenninger et al.	701/29
*	B	US-2004/0095350	05-2004	Kamiyama, Naoya	345/441
*	C	US-5,442,738	08-1995	Chapman et al.	345/639
*	D	US-5,438,513	08-1995	Borkowicz et al.	701/33
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	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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